

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Kyle K. Kirby

Serial No.: 10/673,692

Filed: September 29, 2003

For: METHOD FOR CREATING
ELECTRICAL PATHWAYS FOR
SEMICONDUCTOR DEVICE
STRUCTURES USING LASER
MACHINING PROCESSES

Confirmation No.: 4168

Examiner: M. Estrada

Group Art Unit: 2823

Attorney Docket No.: 2269-5665US
(2002-1291.00/US)

VIA ELECTRONIC FILING

February 25, 2008

COMMENTS ON STATEMENT OF REASONS FOR ALLOWANCE

Mail Stop Issue Fee
Commissioner for Patents
PO Box 1450
Alexandria, VA 22313-1450

Sir:

Although no Statement of Allowable Subject Matter was set forth by the Examiner in the Notice of Allowance mailed November 29, 2007, the Examiner did set forth a statement of reasons for the indication of allowable subject matter in an Office communication mailed July 26, 2007 with respect to the subject matter of claims 22 through 27. This communication sets forth Applicant's comments, pursuant to 37 C.F.R. §1.104(e), to that statement, in which the Examiner indicated that "there is no disclosure in the prior art of ablating one or more

depressions in a surface of the at least one sidewall of the semiconductor substrate to define at least one electrical conductor.”

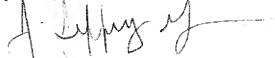
Applicant concurs with the reasons as stated by the Examiner insofar as they comprise a summary, which is exemplary and not limiting. However, the scope of the claims is based on the actual language of the claims and equivalents thereof, and not on a paraphrase or summary of the claim language.

Independent claim 22, as allowed, recites features and methodology in addition to, and in different language than, those described in the Examiner’s statement of July 26, 2007. Furthermore, the dependent claims depending from claim 22 recite elements in addition to those of independent claim 22, which are also not reflected in the Examiner’s statement of July 26, 2007. Such additional elements, in combination with those of the independent claim from which each claim depends, provide additional reasons for patentability. Accordingly, the scope of the claims must be determined from the literal language of each as a whole, as well as all equivalents thereof.

To the extent that the Examiner’s reasons for allowance as stated are not relevant to, or wholly encompassing of, a particular claim, independent or dependent, Applicants assume that (pursuant to 37 C.F.R. §1.104(e)) the Examiner has determined that the record of the prosecution as a whole of the application makes clear the reasons for allowing those claims. Further, it appears, pursuant to M.P.E.P. 1302.14, that the Examiner’s Statements of Allowable Subject Matter are not intended to encompass all of the reasons for allowance.

Serial No. 10/673,692

Respectfully submitted,

A handwritten signature in black ink, appearing to read "J. Jeffrey Guin", with a long horizontal flourish extending to the right.

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Date: February 25, 2008
JJG/djp:slm
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